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PCKEL14

2.5 V/3.3 V PECL/ECL 1:5 clock distribution chip Rev. 01 — 14 October 2002

Product data

Description 1.

The PCKEL14 is a low skew 1:5 clock distribution chip designed explicitly for low skew clock distribution applications. The device can be driven by either a differential or single-ended ECL, or if positive power supplies are used, PECL input signal. The PCKEL14 is designed to operate in ECL or PECL mode for a voltage supply range of -2.375 V to -3.8 V (or 2.375 V to 3.8 V).

The PCKEL14 features a multiplexed clock input to allow for the distribution of a lower speed scan or test clock along with the high speed system clock. When LOW (or left open and pulled LOW by the input pull-down resistor), the SEL pin will select the differential clock input.

The common enable (\overline{EN}) is synchronous, so that the outputs will only be enabled/disabled when they are already in the LOW state. This avoids any chance of generating a runt clock pulse when the device is enabled/disabled, as can happen with an asynchronous control. The internal flip-flop is clocked on the falling edge of the input clock, therefore all associated specification limits are referenced to the negative edge of the clock input.

The V_{BB} pin (an internally generated voltage supply) is available to this device only. For single-ended conditions, the unused differential input is connected to V_{BB} as a switching reference voltage. V_{BB} may also rebias AC-coupled inputs. When used, decouple V_{BB} and V_{CC} via a 0.01 μF capacitor and limit current sourcing or sinking to 0.1 mA. When not used, V_{BB} should be left open.

2. **Features**

- 50 ps output-to-output skew at 3.3 V
- Synchronous enable/disable
- Multiplexed clock input
- ESD protection: > 2.5 kV HBM
- The PCK series contains temperature compensation
- PECL mode operating range: $V_{CC} = 2.375 \text{ V}$ to 3.8 V, with $V_{EE} = 0 \text{ V}$
- NECL mode operating range: $V_{CC} = 0$ V, with $V_{EE} = -2.375$ V to -3.8 V
- Internal 75 k Ω pull-down resistors on all inputs, plus a 37.5 k Ω pull-up on $\overline{\text{CLK}}$
- Q output will default LOW with inputs open or at V_{EE}
- Meets or exceeds JEDEC spec EIA/JESD78 IC latch-up test
- Moisture sensitivity level 1
- Flammability rating: UL-94 code V-0 @ 1/8"

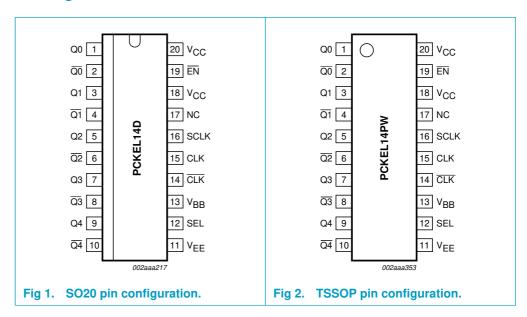




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3. Pinning information

3.1 Pinning



3.2 Pin description

Table 1: Pin description

| Symbol | Pin | Description |
|-----------------------------------|----------------|--|
| Q0-Q4 | 1, 3, 5, 7, 9 | ECL differential clock outputs, non-inverted |
| $\overline{Q0}$ - $\overline{Q4}$ | 2, 4, 6, 8, 10 | ECL differential clock outputs, inverted |
| V _{EE} | 11 | negative supply voltage |
| SEL | 12 | ECL clock select input |
| V_{BB} | 13 | reference voltage output |
| CLK | 14 | ECL differential clock input, inverted |
| CLK | 15 | ECL differential clock input, non-inverted |
| SCLK | 16 | ECL scan clock input |
| NC | 17 | no connect |
| ĒΝ | 19 | ECL synchronous enable, Active-LOW |
| V_{CC} | 18, 20 | positive supply voltage |
| | | |

3.2.1 Power supply connection

CAUTION



All V_{CC} and V_{EE} pins must be connected to an appropriate power supply to guarantee proper operation.

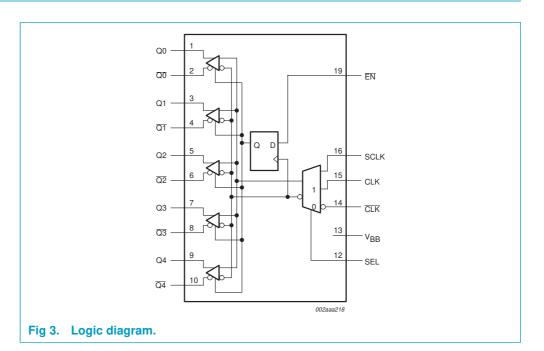
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4. Ordering information

Table 2: Ordering information

| Type number Package | | | | | | | | |
|---------------------|---------|--|----------|--|--|--|--|--|
| | Name | Description | Version | | | | | |
| PCKEL14D | SO20 | plastic small outline package; 20 leads; body width 7.5 mm | SOT163-1 | | | | | |
| PCKEL14PW | TSSOP20 | plastic thin shrink small outline package; 20 leads; body width 4.4 mm | SOT360-1 | | | | | |

5. Logic diagram



CAUTION



All V_{CC} and V_{EE} pins must be connected to an appropriate power supply to guarantee proper operation.

6. Function table

Table 3: Function table

X = Don't care.

| CLK | SCLK | SEL | EN | Q |
|-----|------|-----|----|------|
| L | X | L | L | L |
| Н | X | L | L | Н |
| X | L | Н | L | L |
| X | Н | Н | L | Н |
| X | Χ | Χ | Н | [[1] |

^[1] On next negative transition of CLK or SCLK.

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7. Limiting values

Table 4: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|----------------------|---|---|------|-------|------|
| V _{CC} | power supply | PECL mode; V _{EE} = 0 V | 0 | 4.1 | V |
| V _{EE} | power supply | NECL mode; V _{CC} = 0 V | 0 | -4.1 | V |
| VI | input voltage | PECL mode; $V_{EE} = 0 \text{ V}; V_{I} \leq V_{CC}$ | 0 | 4.1 | V |
| | | NECL mode; $V_{CC} = 0 \text{ V; } V_I \ge V_{EE}$ | 0 | -4.1 | V |
| lo | output current | continuous | - | 50 | mA |
| | | surge | - | 100 | mA |
| I _{BB} | V _{BB} sink/source | | -0.1 | +0.1 | mA |
| T _{amb} | ambient temperature | | -40 | +85 | °C |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| R _{th(j-a)} | thermal resistance from junction to ambient | 0 LFPM | - | 90 | °C/W |
| | | 500 LFPM | - | 60 | °C/W |
| R _{th(j-c)} | thermal resistance from junction to case | std bd | 30 | 35 | °C/W |
| T _{sld} | soldering temperature | < 2 to 3 sec @ 248 °C | - | 265 | °C |
| ESDHBM | electrostatic discharge | Human Body Model; 1.5 k Ω ; 100 pF | - | >2.50 | kV |
| ESDMM | electrostatic discharge | Machine Model; 0 kΩ; 200 pF | - | >100 | V |
| ESCCDM | electrostatic discharge | Charge Device Model | - | >1000 | V |
| | | | | | |

^[1] Maximum ratings are those values beyond which device damage may occur.

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8. Static characteristics

Table 5: PECL DC characteristics^[1]

 $V_{CC} = 2.5 \text{ V}; V_{EE} = 0 \text{ V}^{[2]}$

| Symbol | Parameter | Conditions | | Tam | _{ib} = -40 |) °C | T _{am} | _{ib} = +2 | 5 °C | Tam | _{ib} = +8 | 5 °C | Unit |
|--------------------|--|--------------|-----|------|---------------------|------|-----------------|--------------------|------|------|--------------------|------|------|
| | | | | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | |
| I _{EE} | power supply current | | | - | 28 | 40 | - | 30 | 40 | - | 31 | 42 | mA |
| V _{OH} | HIGH-level output voltage | | [3] | 1325 | 1460 | 1620 | 1435 | 1545 | 1620 | 1475 | 1545 | 1620 | mV |
| V _{OL} | LOW-level output voltage | | [3] | 670 | 805 | 945 | 690 | 795 | 880 | 690 | 795 | 880 | mV |
| V _{IH} | HIGH-level input voltage | single-ended | [4] | 1310 | - | 1620 | 1335 | - | 1620 | 1335 | - | 1620 | mV |
| V _{IL} | LOW-level input voltage | single-ended | [4] | 690 | - | 1025 | 690 | - | 1025 | 690 | - | 1025 | mV |
| V_{BB} | output voltage reference | | | 1.07 | - | 1.25 | 1.15 | - | 1.25 | 1.15 | - | 1.31 | V |
| V _{IHCMR} | HIGH-level input voltage, common mode range (differential) | | [5] | 1.2 | - | 2.1 | 1.2 | - | 2.1 | 1.2 | - | 2.1 | V |
| I _{IH} | HIGH-level input current | | | - | - | 150 | - | - | 150 | - | - | 150 | μΑ |
| I _{IL} | LOW-level input current | CLK | | 0.5 | - | - | 0.5 | - | - | 0.5 | - | - | μА |
| | | CLK | | -300 | - | - | -300 | - | - | -300 | - | - | μΑ |

^[1] Devices are designed to meet the DC specifications shown in this table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 LFPM is maintained.

^[2] Input and output parameters vary 1:1 with V_{CC} . V_{EE} can vary +0.125 V to -1.3 V.

^[3] All loading with 50 Ω to V_{CC} – 2 V.

^[4] Do not use V_{BB} at V_{CC} < 3.0 V.

^[5] V_{IHCMR(min)} varies 1:1 with V_{EE}, V_{IHCMR(max)} varies 1:1 with V_{CC}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal.

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Table 6: Positive DC characteristics^[1]

 $V_{CC} = 3.3 \text{ V; } V_{FF} = 0 \text{ V}^{[2]}$

| Symbol | Parameter | Conditions | Tam | _{ib} = -40 | O°C | T _{amb} = +25 °C | | | Tam | Unit | | |
|-----------------|---|--------------------------------|------|---------------------|------|---------------------------|------|------|------|------|------|----|
| | | | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | |
| I _{EE} | power supply current | | - | 32 | 40 | - | 32 | 40 | - | 34 | 42 | mΑ |
| V_{OH} | HIGH-level output voltage | [3] | 2125 | 2260 | 2420 | 2235 | 2345 | 2420 | 2275 | 2345 | 2420 | mV |
| V_{OL} | LOW-level output voltage | [3] | 1470 | 1605 | 1745 | 1490 | 1595 | 1680 | 1490 | 1595 | 1680 | mV |
| V_{IH} | HIGH-level input voltage | single-ended | 2110 | - | 2420 | 2135 | - | 2420 | 2135 | - | 2420 | mV |
| V_{IL} | LOW-level input voltage | single-ended | 1490 | - | 1825 | 1490 | - | 1825 | 1490 | - | 1825 | mV |
| V_{BB} | output voltage reference | | 1.87 | - | 2.05 | 1.95 | - | 2.05 | 1.95 | - | 2.11 | V |
| V_{IHCMR} | HIGH-level input | $V_{p-p} < 500 \text{ mV}$ [4] | 1.3 | - | 2.9 | 1.2 | - | 2.9 | 1.2 | - | 2.9 | V |
| | voltage, common mode range (differential) | $V_{p-p} \ge 500 \text{ mV}$ | 1.5 | - | 2.9 | 1.4 | - | 2.9 | 1.4 | - | 2.9 | V |
| I _{IH} | HIGH-level input current | | - | - | 150 | - | - | 150 | - | - | 150 | μΑ |
| I _{IL} | LOW-level input | CLK | -300 | - | - | -300 | - | - | -300 | - | - | μΑ |
| | current | others | 0.5 | - | - | 0.5 | - | - | 0.5 | - | - | μΑ |

^[1] Devices are designed to meet the DC specifications shown in this table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 LFPM is maintained.

^[2] Input and output parameters vary 1:1 with V_{CC} . V_{EE} can vary $\pm 0.3~V$.

^[3] Outputs are terminated through a 50 Ω resistor to V_{CC} – 2V.

^[4] V_{IHCMR(min)} varies 1:1 with V_{EE}, V_{IHCMR(max)} varies 1:1 with V_{CC}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between V_{p-p(min)} and 1 V.

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Table 7: Negative DC characteristics^[1]

 $V_{CC} = 0.0 \text{ V}; V_{EE} = -3.8 \text{ V to } -2.375 \text{ V}^{[2]}$

| Symbol | Parameter | Conditions | Tan | $_{1b} = -40$ | °C | Tan | _{1b} = +25 | °C | Tan | _{nb} = +85 | S °C | Unit |
|-----------------|--|--------------------------------|-------|---------------|-------|-------|---------------------|-------|-------|---------------------|-------|------|
| | | | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | |
| I _{EE} | power supply current | | - | 32 | 40 | - | 32 | 40 | - | 34 | 42 | mA |
| V _{OH} | HIGH-level output voltage | [3] | -1175 | -1040 | -880 | -1065 | -955 | -880 | -1025 | -955 | -880 | mV |
| V_{OL} | LOW-level output voltage | [3] | -1830 | -1695 | -1555 | -1810 | -1705 | -1620 | -1810 | -1705 | -1620 | mV |
| V_{IH} | HIGH-level input voltage | single-ended | -1190 | - | -880 | -1165 | - | -880 | -1165 | - | -880 | mV |
| V_{IL} | LOW-level input voltage | single-ended | -1810 | - | -1475 | -1810 | - | -1475 | -1810 | - | -1475 | mV |
| V_{BB} | output voltage reference | | -1.43 | - | -1.25 | -1.35 | - | -1.25 | -1.35 | - | -1.19 | V |
| V_{IHCMR} | HIGH-level input | $V_{p-p} < 500 \text{ mV}$ [4] | -2.0 | - | -0.4 | -2.1 | - | -0.4 | -2.1 | - | -0.4 | V |
| | voltage, common mode range (differential) | $V_{p-p} \ge 500 \text{ mV}$ | -1.8 | - | -0.4 | -1.9 | - | -0.4 | -1.9 | - | -0.4 | V |
| I _{IH} | HIGH-level input current | | - | - | 150 | - | - | 150 | - | - | 150 | μΑ |
| I _{IL} | LOW-level input | CLK | -300 | - | - | -300 | - | - | -300 | - | - | μΑ |
| | current | others | 0.5 | - | - | 0.5 | - | - | 0.5 | - | - | μΑ |

^[1] Devices are designed to meet the DC specifications shown in this table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 LFPM is maintained.

^[2] Input and output parameters vary 1:1 with V_{CC} . V_{EE} can vary ± 0.3 V.

^[3] Outputs are terminated through a 50 Ω resistor to V_{CC} – 2 V.

^[4] V_{IHCMR(min)} varies 1:1 with V_{EE}, V_{IHCMR(max)} varies 1:1 with V_{CC}. The V_{IHCMR} range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between V_{p-p(min)} and 1 V.

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9. Dynamic characteristics

Table 8: AC characteristics

 $(V_{CC} = 2.375 \ V \ to \ 3.8 \ V; \ V_{EE} = 0 \ V) \ or \ (V_{CC} = 0 \ V; \ V_{EE} = -2.375 \ V \ to \ -3.8 \ V) \ {}^{[1]}$

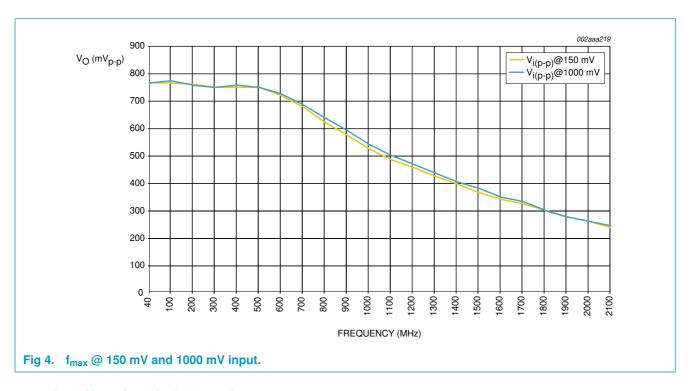
| Symbol | Parameter | Conditions | | Tami | _b = -4 | 0 °C | $T_{amb} = +25 ^{\circ}C$ | | | Tam | Unit | | |
|--------------------------------|-------------------------------|---------------------------------|-------|------|-------------------|------|----------------------------|-----|------|-----|------|------|-----|
| | | | | /lin | Тур | Max | Min | Тур | Max | Min | Тур | Max | |
| f _{max} | maximum toggle frequency | see Figure 4 | | - | > 1 | - | - | > 1 | - | - | > 1 | - | GHz |
| t _{PLH} | LOW-to-HIGH propagation delay | CLK to Q (diff); 3.3 V | 4 | 100 | - | 720 | 450 | - | 780 | 475 | - | 830 | ps |
| | CLK to Q (diff); 2.5 V | 4 | 100 | - | 800 | 450 | - | 940 | 500 | - | 970 | ps | |
| t _{PHL} | HIGH-to-LOW | CLK to Q (SE) | 3 | 330 | - | 770 | 350 | 680 | 830 | 370 | - | 880 | ps |
| | propagation delay | SCLK to Q | 3 | 330 | - | 770 | 350 | 680 | 830 | 370 | - | 880 | ps |
| t _{SKEW} | skew time | part-to-part | | - | - | 200 | - | - | 200 | - | - | 200 | ps |
| | | within-device; 3.3 V | [2] | - | - | 50 | - | - | 50 | - | - | 50 | ps |
| | | within-device; 2.5 V | [2] | - | - | 70 | - | - | 70 | - | - | 70 | ps |
| t _{JITTER} | cycle-to cycle jitter | | | - | 0.2 | < 1 | - | 0.2 | < 1 | - | 0.2 | < 1 | ps |
| t _{su} | EN set-up time | | | 0 | - | - | 0 | - | - | 0 | - | - | ps |
| t _h | EN hold time | | | 0 | - | - | 0 | - | - | 0 | - | - | ps |
| $V_{i(p-p)}$ | input swing CLK | | [3] 1 | 50 | - | 1000 | 150 | - | 1000 | 150 | - | 1000 | mV |
| t _r /t _f | output rise/fall times | Q pins (20% - 80%); 3.3 V | 2 | 230 | - | 500 | 230 | - | 500 | 230 | - | 500 | ps |
| | | Q pins (20% - 80%); 2.5 V | 2 | 230 | - | 600 | 230 | - | 600 | 230 | - | 625 | ps |

^[1] V_{EE} can vary ± 0.3 V.

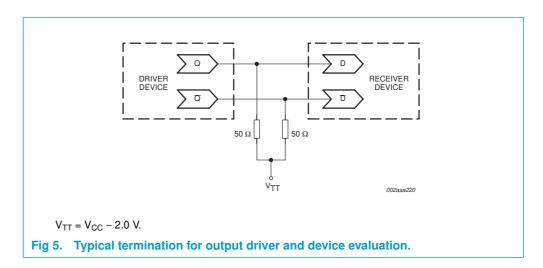
^[2] Skews are specified for identical LOW-to-HIGH or HIGH-to-LOW transitions.

^[3] $V_{i(p-p)(min)}$ is minimum input swing for which AC parameters are guaranteed.

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10. Application information

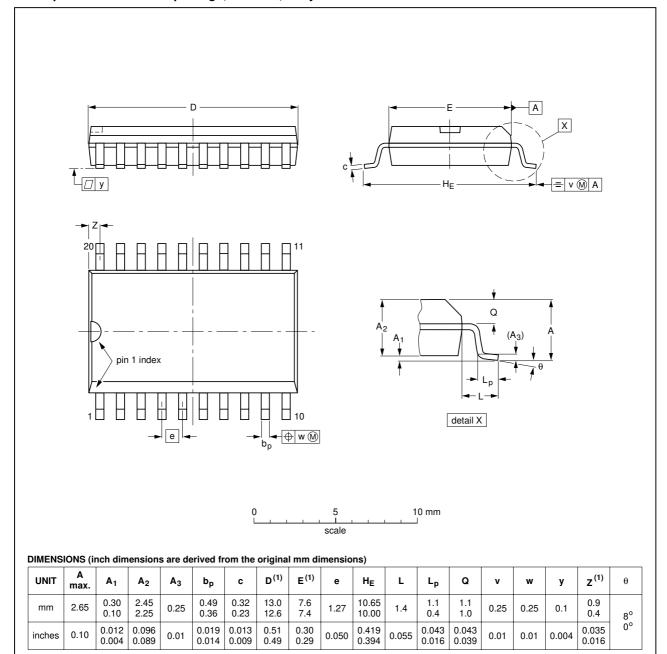


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11. Package outline

SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1



Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

| OUTLINE | | REFERENCES | | | | ISSUE DATE |
|----------|--------|------------|------|--|------------|----------------------------------|
| VERSION | IEC | JEDEC | EIAJ | | PROJECTION | ISSUE DATE |
| SOT163-1 | 075E04 | MS-013 | | | | -97-05-22 99-12-27 |

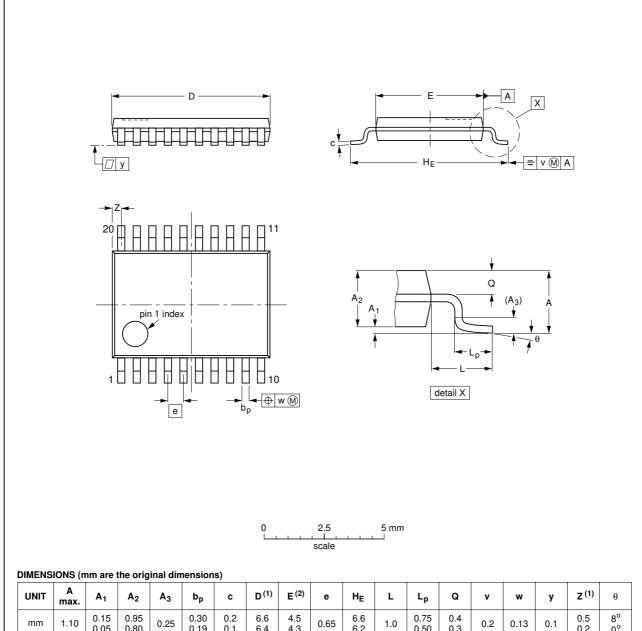
Fig 6. SO20 package outline (SOT163-1).

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TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1



| UNIT | A max. | A ₁ | A ₂ | A ₃ | bp | С | D ⁽¹⁾ | E (2) | е | HE | L | Lp | Q | v | w | у | Z ⁽¹⁾ | θ |
|------|-----------|----------------|----------------|----------------|--------------|------------|------------------|------------|------|------------|-----|--------------|------------|-----|------|-----|------------------|----------|
| mm | 1.10 | 0.15 0.05 | 0.95 0.80 | 0.25 | 0.30 0.19 | 0.2 0.1 | 6.6 6.4 | 4.5 4.3 | 0.65 | 6.6 6.2 | 1.0 | 0.75 0.50 | 0.4 0.3 | 0.2 | 0.13 | 0.1 | 0.5 0.2 | 8° 0° |

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

| OUTLINE | | REFER | ENCES | EUROPEAN | ISSUE DATE |
|----------|-----|--------|-------|------------|----------------------------------|
| VERSION | IEC | JEDEC | EIAJ | PROJECTION | ISSUE DATE |
| SOT360-1 | | MO-153 | | | -95-02-04 99-12-27 |

Fig 7. TSSOP20 package outline (SOT360-1).

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12. Soldering

12.1 Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *Data Handbook IC26; Integrated Circuit Packages* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

12.2 Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferable be kept below 220 °C for thick/large packages, and below 235 °C small/thin packages.

12.3 Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
 - larger than or equal to 1.27 mm, the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;
 - smaller than 1.27 mm, the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

• For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

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During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C. A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

12.4 Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to $300\,^{\circ}$ C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

12.5 Package related soldering information

Table 9: Suitability of surface mount IC packages for wave and reflow soldering methods

| Package ^[1] | Soldering method | | | | | |
|---|-----------------------------------|-----------------------|--|--|--|--|
| | Wave | Reflow ^[2] | | | | |
| BGA, LBGA, LFBGA, SQFP, TFBGA, VFBGA | not suitable | suitable | | | | |
| HBCC, HBGA, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, HVQFN, HVSON, SMS | not suitable ^[3] | suitable | | | | |
| PLCC ^[4] , SO, SOJ | suitable | suitable | | | | |
| LQFP, QFP, TQFP | not recommended ^{[4][5]} | suitable | | | | |
| SSOP, TSSOP, VSO | not recommended ^[6] | suitable | | | | |

- [1] For more detailed information on the BGA packages refer to the (*LF*)*BGA Application Note* (AN01026); order a copy from your Philips Semiconductors sales office.
- [2] All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods.
- [3] These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.
- [4] If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
- [5] Wave soldering is suitable for LQFP, QFP and TQFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.
- [6] Wave soldering is suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

13. Revision history

Table 10: Revision history

| Rev | Date | CPCN | Description | |
|-----|----------|------|---|--|
| 01 | 20021014 | - | Product data; initial version (9397 750 09564). | |
| | | | Engineering Change Notice 853-2372 2877 (date: 20020909). | |

9397 750 09564

2.5 V/3.3 V PECL/ECL 1:5 clock distribution chip

14. Data sheet status

| Level | Data sheet status ^[1] | Product status ^{[2][3]} | Definition |
|-------|----------------------------------|----------------------------------|--|
| I | Objective data | Development | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice. |
| II | Preliminary data | Qualification | This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product. |
| III | Product data | Production | This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). |

- [1] Please consult the most recently issued data sheet before initiating or completing a design.
- [2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- [3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

15. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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